

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10653021	LUO ET AL.
	Examiner	Art Unit
	Chawan, Sheela C	2624

SEARCHED

Class	Subclass	Date	Examiner
382	117,167,165,275,164,103,274,118,199,173,162,190,115,	1/22/07	scc
348	239,241,	"	"
396	191,198,	"	"
426	72,311,620,640,641,658	"	"

SEARCH NOTES

Search Notes	Date	Examiner
EAST,US-PGPUB,USPAT,EPO,JPO,DERWENT, IBM-TDB.	1/22/07	SCC
INVENTOR NAME SEARCH.	"	"

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner